Notice of References Cited Application/Control No. 10/535,741 Examiner Savitri Mulpuri Applicant(s)/Patent Under Reexamination NAKAHATA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0272572	12-2006	Uematsu et al.	117/084
*	В	US-2006/0236922	10-2006	Ishibashi et al.	117/094
*	C	US-2003/0209185	11-2003	Ueno et al.	117/2
*	۵	US-2006/0281328	12-2006	Nishiura et al.	438/758
*	ш	US-2005/0164419	07-2005	Hirota et al.	438/046
*	۴	US-6,488,767	12-2002	Xu et al.	117/2
*	G	US-7,125,801	10-2006	Minemoto et al.	438/691
*	Ι	US-2002/0037599	03-2002	Ishida et al.	438/29
	-	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	200404281865	07-2004	JP	Namiki Precision Jewll Co	
	0	•				
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.